

Single Chip 3-Axis Magnetic Sensor QMC6983



The QMC6983 is a single chip three-axis magnetic sensor. This surfacemount, small sized chip has integrated magnetic sensors with signal condition ASIC, targeted for applications such as compassing, map rotation, gaming and personal navigation in mobile and personal hand-held devices.

The QMC6983 is based on our state-of-the-art, high resolution, magnetoresistive technology. Along with custom-designed 16-bit ADC ASIC, it offers the advantages of low noise, high accuracy, low power consumption, offset cancellation and temperature compensation. QMC6983 enables 1° to 2° compass heading accuracy. The I²C serial bus allows for easy interface.

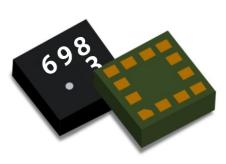
The QMC6983 is in a 1.6x1.6x0.75mm³ surface mount 12-pin leadless grid array (LGA) package.

FEATURES

- 3-Axis Magneto-Resistive Sensors in a 1.6x1.6x0.75 mm³ Land Grid Array Package (LGA), guaranteed to operate over an extended temperature range of -40 °C to +85 °C.
- 16 Bit ADC With Low Noise AMR Sensors Achieves 2 milli-Gauss Field Resolution
- Wide Magnetic Field Range (±20 Gauss)
- Temperature Compensated Data Output and Temperature Output
- I²C Interface with Standard and Fast Modes.
- Built-In Self-Test
- Wide Range Operation Voltage (2.16V To 3.6V) and Low Power Consumption (75µA)
- Lead Free Package Construction
- Software And Algorithm Support Available

BENEFIT

- Small Size for Highly Integrated Products. Signals Have Been Digitized And Calibrated.
- Enables 1° To 2° Degree Compass Heading Accuracy, Allows for Pedestrian Navigation and LBS Applications
- Maximizes Sensor's Full Dynamic Range and Resolution
- Automatically Maintains Sensor's Sensitivity Under Wide Operating Temperature Range
- High-Speed Interfaces for Fast Data Communications. Maximum 200Hz Data Output Rate
- Enables Low-Cost Functionality Test After Assembly in Production
- Compatible with Battery Powered Applications
- RoHS Compliance
- Compassing Heading, Hard Iron, Soft Iron, and Auto Calibration Libraries Available



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1 INTERNAL SCHEMATIC DIAGRAM

1.1 Internal Schematic Diagram

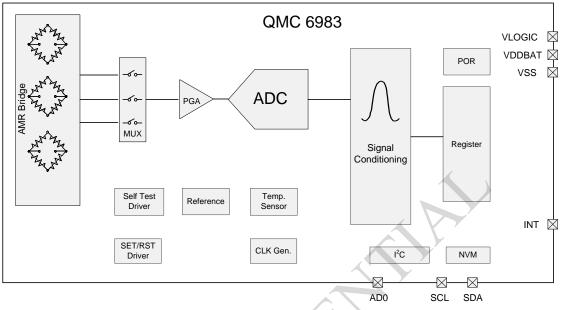


Figure 1. Block Diagram

Table 1. Block Function

Block	Function					
AMR Bridge	3 axis magnetic sensor					
MUX	Multiplexer for sensor channels					
PGA	Programmable gain amplifier for sensor signals					
ADC	16 bit Analog-to-Digital converter					
Signal Conditioning	Digital blocks for magnetic signal calibration and compensation					
I ² C	Interface logic data I/O					
NVM	Non-Volatile memory for calibrated parameters					
Self-Test Driver	Internal driver to generate self-test stimulus					
SET/RST Driver	Internal driver to initialize magnetic sensor					
Reference	Voltage/Current reference for internal biasing					
Clock Gen.	Internal oscillator for internal operation					
POR	Power on reset					
Temperature Sensor	Temperature sensor for internal sensitivity /offset compensation, and					
	temperature output					

2 SPECIFICATIONS AND I/O CHARACTERISTICS

2.1 **Product Specifications**

Table 2. Specifications (* Tested and specified at 25°C except stated otherwise.)

Parameter	Conditions	Min	Тур	Max	Unit
Supply Voltage	VDDBAT	2.16		3.6	V
I/O Voltage	VLOGIC	1.65		3.6	V
Standby Current	Total Current on VDDBAT and VLOGIC		3		μA

Parameter	Condition	S	Min	Тур	Max	Unit
	Low/Hig h Power	ODR = 10Hz		75/100		μΑ
Continuous Mode Current	Mode	ODR = 50Hz		150/250		μA
Current	(OSR=6	ODR = 100Hz		250/450		μA
	4 or 512)	ODR = 200Hz		450/850		μA
Peak Current in Active State	Peak Curr and VLOG Measurem			2.6		mA
Sensor Field Range	Full Scale		-20		+20	Gauss
Dynamic Output Field Range	Programm	able	±2		±20	Gauss
	Field Rang			10000		LSB/G
Sensitivity [1]	Field Rang			2500		LSB/G
Contoninty	Field Rang			1666		LSB/G
	Field Rang			1000		LSB/G
Linearity (Best fit linear		ge = ±2G (X-Y) (Z Axis)		0.2 1.0	$\boldsymbol{\langle}$	%FS
curve)	Field Rang	ge = ±8G (X-Y) (Z Axis)		0.6 1.5		%FS
Hysteresis	All Ranges (X-Y Axis) (Z Axis)			0.3 2	1	%FS
Cross Axis Sensitivity	Cross field = 1 gauss, Happlied = ± 2 gauss			0,1		%/G
Offset				±10		mG
Sensitivity Tempco	Ta = -40℃	~85 ℃		±0.05		%/℃
Temperature Sensor Sensitivity	Ta = -40℃	~85 ℃) y	100		LSB/°C
Digital Resolution	Change w		0.1		1.0	mGauss
Field Resolution	Standard o Data, FS ±	deviation 100 -2G (X-Y) (Z)		2 20		mGauss
Output Data Rate	Programm 10Hz/50H	able. z/100Hz/200Hz	10		200	Samples /sec
Self-Test	Field Range = $\pm 8G$ (X-Y) (Z) Field Range = $\pm 20G$ (X-Y) (Z)			2600 -6500 1000 -2500		LSB
X-Y-Z Orthogonality	Sensitivity Directions			90±1		degree
Operating Temperature			-40		85	°C
ESD	HB Mode		2000			V
200	Machine N	lodel	200			v

Note [1]: Sensitivity is calibrated at zero field, it is slightly decreased at high fields.

2.2 Absolute Maximum Ratings

Table 3. Absolute Maximum Ratings (Tested at 25°C except stated otherwise.)

Parameter	MIN.	MAX.	Units
VDDBAT	-0.3	5.4	V
VLOGIC	-0.3	5.4	V
Storage Temperature	-40	125	°C
Exposed to Magnetic Field (all directions)		50000	Gauss
Reflow Classification	MSL 3, 260 °C F	Peak Temperature)

2.3 I/O Characteristics

Table 4. I/O Characteristics

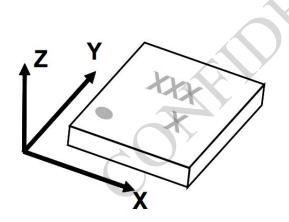
Parameter	Symbol	Pin	Condition	Min.	TYP.	Max.	Unit		
Voltage Input	V _{IH} 1	SDA, SCL		0.7*VLO		VLOGIC	V		
High Level 1				GIC		+0.3			
Voltage Input	V _{IL} 1	SDA, SCL		-0.3		0.3*VLO	V		
Low Level 1						GIC			
Voltage Output	V _{OH}	INT	Output Current	0.8*VLO			V		
High Level			≥-100uA	GIC					
Voltage Output	V _{OL}	INT, SDA	Output Current			0.2*VLO	V		
Low Level			≤100uA(INT)			GIC			
			Output Current						
			≤1mA (SDA)						

3 PACKAGE PIN CONFIGURATIONS

3.1 Package 3-D View

Arrow indicates direction of magnetic field that generates a positive output reading in normal measurement configuration.

< QMC6983 >



Figu	ire 2.	Package	3-D	View
94		i uonago		

PIN	PIN	I/O	Power	TYPE	Function
No.	NAME		Supply		
1	INT	0	VLOGIC	CMOS	Data Ready Interrupt Output
2	NC				Not Connected
3	SCL	1	VLOGIC	CMOS	I ² C Clock
4	SDA	I/O	VLOGIC	CMOS	I ² C Data
5	RSV				Keep This PIN Floating
6	VLOGIC	-	-	Power	Digital Power Supply
7	NC				Not Connected
8	NC				Not Connected
9	NC				Not Connected
10	AD0	1	VDDBAT	CMOS(Analog)	I ² C Address

Table 5 Pin Configurations

11	VSS	-	-	Power	Ground PIN
12	VDDBAT	-	-	Power	Analog Power Supply

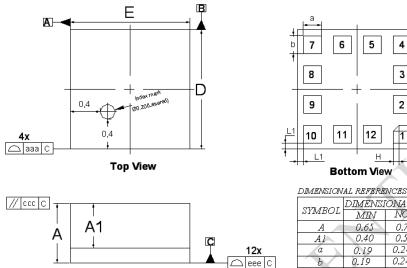
3.2 Package Outlines

3.2.1 Package Type

LGA (Land Grid Array)

3.2.2 Package Size:

1.6mm (Length)*1.6mm (Width)*0.75mm (Height)



	<u></u>		1 119 11 1					
Bottom View								
DIMENSIONAL REFERENCES Units:mm								
COR CDOL	DIMENSI	ONAL RE	QMTS	SYMBOL	Tolerance of Form & Position			
SYMBOL	MIN	NOM	MAX	aaa	0.10			
А	0.65	0.75	0.85	eee	0.10			
Al	0.40	0.50	0.60	ccc	0.08			
a	0.19	0.24	0.29					
Ь	0.19	0.24	0.29	1				
D	1.50	1.60	1.70]				
E	1.50	1.60	1.70					
е		0.40 BCS						
H	(0.08 BCS						
Ll	(0.08 REF]				

PIN #1

Figure 3. Package Size

3.2.3 Marking:

Tracking code: $X_1X_2X_3$ X_1 : Year code X_2X_3 : Lot code X4: Product number (Digit 1 means QMC6983)

Side View

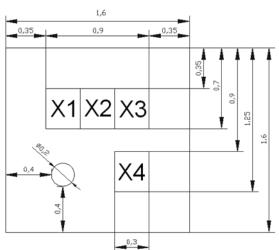
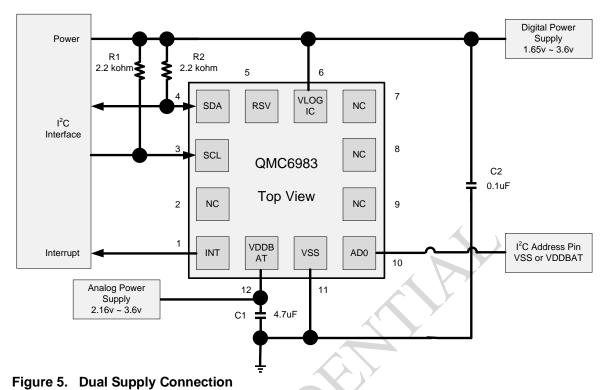


Figure 4. Chip Marking

4 EXTERNAL CONNECTION

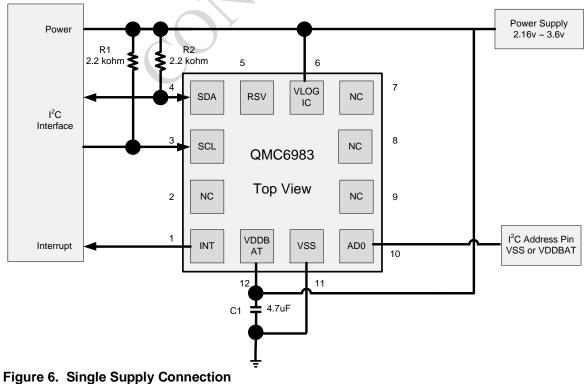
4.1 Dual Supply Connection

Host CPU



4.2 Single Supply connection

Host CPU



4.3 Mounting Considerations

The following is the recommend printed circuit board (PCB) footprint for the QMC6983. Due to the fine pitch of the pads, the footprint should be properly centered in the PCB.

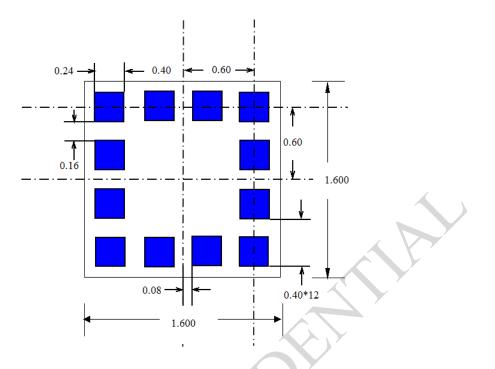


Figure 7. QMC6983 PCB footprint

4.4 Layout Considerations

Besides keeping all components that may contain ferrous materials (nickel, etc.) away from the sensor on both sides of the PCB, it is also recommended that there is no conducting copper line under/near the sensor in any of the PCB layers.

4.4.1 Solder Paste

A 4 mil stencil and 100% paste coverage is recommended for the electrical contact pads.

4.4.2 Reflow Assembly

This device is classified as MSL 3 with 260°C peak reflow temperature. As specified by JEDEC, parts with an MSL 3 rating require baking prior to soldering, if the part is not kept in a continuously dry (< 10% RH) environment before assembly. Reference IPC/JEDEC standard J-STD-033 for additional information.

No special reflow profile is required for QMC6983, which is compatible with lead eutectic and lead-free solder paste reflow profiles. QST recommends adopting solder paste manufacturer's guidelines. Hand soldering is not recommended.

4.4.3 External Capacitors

The external capacitors C1 should be ceramic type with low ESR characteristics. The exact ESR value is not critical, but values less than 200 milli-ohms are recommended. Reservoir capacitor C1 is nominally 4.7 μ F in capacitance. Low ESR characteristics may not be in many small SMT ceramic capacitors (0402), so be prepared to up-size the capacitors to gain low ESR characteristics.

5 BASIC DEVICE OPERATION

5.1 Anisotropic Magneto-Resistive Sensors

The QMC6983 magneto-resistive sensor circuit consists of tri-axial sensors and application specific support circuits to measure magnetic fields. With a DC power supply is applied to the sensor two terminals, the sensor converts any incident magnetic field in the sensitive axis directions to a differential voltage output.

The device has an offset cancellation function to eliminate sensor and ASIC offsets. It also applies a self-aligned magnetic field to restore magnetic state before each measurement to ensure high accuracy. Because of these features, the QMC6983 doesn't need to calibrate every time in most of application situations. It may need to be calibrated once in a new system or a system changes a new battery.

5.2 Power Management

There are two power supply pins to the device. VDDBAT provides power for all the internal analog and digital functional blocks. VLOGIC provides power for digital I/O and logic. It is possible to work with VLOGIC equal to VDDBAT, the single supply mode, or with VLOGIC lower than VDDBAT, the dual supply mode.

The device should turn-on both power pins in order to operate properly. When the device is powered on, all registers are reset by POR, then the device transits to the standby mode and waits for further commends.

Table 6 provides references for four power states. Transitions between power state 2 and power state 3 are prohibited, due to leakage current concerns.

Power State	VDDBAT	VLOGIC	Power State description	
1	0V	0V	Device Off, No Power Consumption	
2	0V	1.65v~3.6v	Device Off, Unpredictable Leakage Current on	
			VLOGIC due to Floating Node.	
3	2.16v~3.6v	0	Device Off, Same Current as Standby Mode	
4	2.16v~3.6v	1.65v~3.6v	Device On, Normal Operation Mode, Enters Standby	
			Mode after POR	

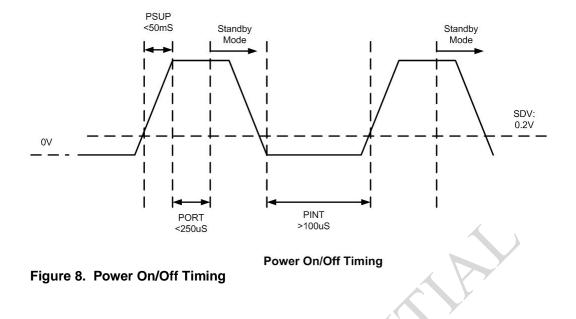
Table 6: Power States

5.3 Power On/Off Time

After the device is powered on, some time periods are required for the device fully functional. The external power supply requires a time period for voltage to ramp up (PSUP), it is typically 50 milli-second. However it isn't controlled by the device. The Power –On –Reset time period (PORT) includes time to reset all the logics, load values in NVM to proper registers, enter the standby mode and get ready for analogy measurements. The power on/off time related to the device is in Table 7.

Table 7. Time Required for Powe	r On/Off
---------------------------------	----------

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
POR	PORT	Time Period After VDDBAT			350	uS
Completion		and VLOGIC at Operating				
Time		Voltage to Ready for I ² C				
		Commend and Analogy				
		Measurement.				
Power off	SDV	Voltage that Device Considers			0.2	V
Voltage		to be Power Down.				
Power on	PINT	Time Period Required for	100			uS
Interval		Voltage Lower Than SDV to				
		Enable Next POR				



5.4 Communication Bus Interface I²C and Its Addresses

This device will be connected to a serial interface bus as a slave device under the control of a master device, such as the processor. Control of this device is carried out via I²C.

This device is compliant with I²C -Bus Specification, document number: 9398 393 40011. As an I²C compatible device, this device has a 7-bit serial address and supports I²C protocols. This device supports standard and fast speed modes, 100kHz and 400kHz, respectively. External pull-up resistors are required to support all these modes.

There are two I²C addresses selected by connecting pin 10 (AD0) to VSS or VDDBAT. The first six MSB are hardware configured to "000110" and the LSB can be configured by AD0.

Table 8.	I ² C Address	Options
----------	--------------------------	---------

AD0 (pin 10)	I ² C Slave Address(HEX)	I ² C Slave Address(BIN)
Connect to VSS	0CH	0001100
Connect to VDDBAT	0DH	0001101

If more I²C address options are required, please contact factory for metal layer changes.

5.5 Internal Clock

The device has an internal clock for internal digital logic functions and timing management. This clock is not available to external usage.

5.6 Temperature Compensation

Temperature compensation of the measured magnetic data is enabled by default at the factory. Temperature measured by the built-in temperature sensor will be used to compensate the magnetic sensor's sensitivity

changes due to temperatures. The compensated magnetic sensor data is placed in the Output Data Registers automatically.

5.7 Temperature Output

QMC6983 has a built-in temperature sensor, it can provide temperature reading for other applications. The output is placed in Temperature Output Registers (07H and 08H). The temperature is calibrated for its sensitivity.

6 MODES OF OPERATION

6.1 Modes Transition

The device has three different operational modes, controlled by register (09H), mode bits. The main purpose of these modes is for power management and self-assessment. The modes can be transited from one to another, as shown below, through I²C commends of changing mode bits. The default mode is Standby.

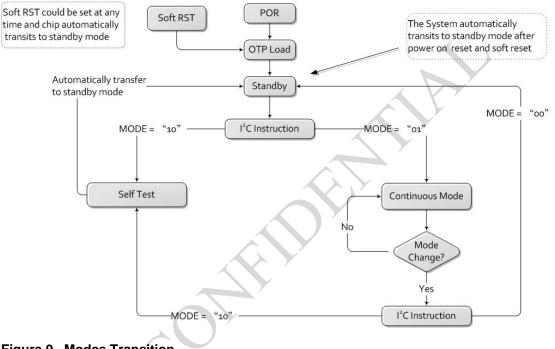


Figure 9. Modes Transition

6.2 Description of Modes

6.2.1 Continuous-Measurement Mode

During the continuous-measurement mode (mode bits= 01), the magnetic sensor continuously makes measurements and places measured data in data output registers. The field range (or sensitivity) and data output rate registers are also located in the control register (09H), they should be set up properly for your applications in the continuous-measurement mode.

For example, if the application requires output date rate 50Hz, the ODR bit in control register (09H) should be 01. If the field range is +/-12 Gauss, the RNG =10.

The over sample rate is optional for you to use. The default is OSR=00, if your application has enough resolution and need low power consumption, you may reduce OSR to a lower number, such as OSR=10 (128) or OSR =11 (64).

In the continuous-measurement mode, the magnetic sensor data are automatically compensated for offset and temperature effects. The gains are calibrated in the factory.

6.2.1.1 Normal Read Sequence

Complete magnetometer data read-out can be done as follow steps.

- ♦ Check INT pin or by polling DRDY in Register 06H
- Read DRDY in Register 06H (if polling, it's unnecessary) DRDY: Data ready ("1") or Not ("0").
 DOP: Any data has been missed ("4") or not ("0").
 - DOR: Any data has been missed ("1") or not ("0")
- \diamond Read measured data, if any of the six data register is accessed, DRDY and DOR turn to "0".
- Data protection, if any of the six data register is accessed, data protection starts. During Data protection period, data register cannot be updated until the last bits 05H (ZOUT [15:8]) have been read.

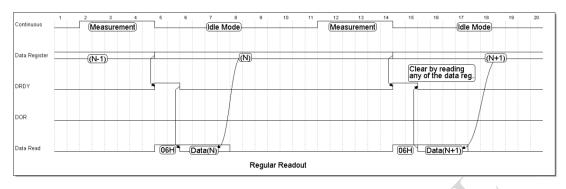


Figure 10. Normal Read Sequence

6.2.1.2 Data Read Sequence Occurs at Measurement

During measurement, it's possible to read data register which keep the previous measured data. Therefore, no interrupt (DRDY bit) will be set if data reading occurs at the middle of measurement.

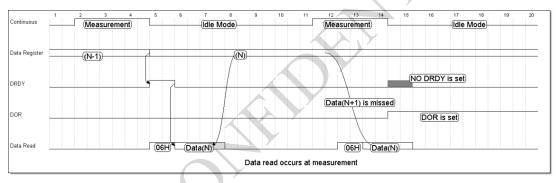


Figure 11 Data Read Sequence at Measurement

6.2.1.3 Data Not Read

If Nth data is skipped, the current data will be flushed by next coming data. In this case, interrupt (DRDY bit) keeps high until data is read. DOR bit is set to "1" which indicates a set of measurement data has been lost. DOR bit turns to "0" once 06H is accessed in next data read operation

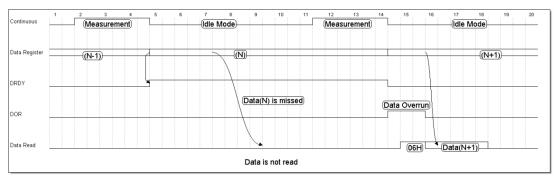


Figure 12. Sequence When Data Not Read

6.2.1.4 Data Locks Until Next Measurement Ends

Data lock is activated once any of the data register is accessed. If 05H (data unlock) is not accessed until next measurements ends, current data blocks next data to update data register. In this case, DOR bit is also set to "1" until 06H is accessed in next data read.

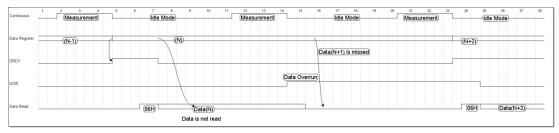


Figure 13. Sequence When Data Locks

6.2.1.5 Interrupt

An interrupt is generated on INT pin each time that magnetic field is measured. The interrupt can be disabled by set 0AH[0] = 1.

6.2.2 Standby Mode

Standby mode is the default state of QMC6983 upon POR and soft reset, only few function blocks are activated in this mode, which keeps power consumption as low as possible. In this state, register values are hold on by an ultra-low power LDO, I²C interface can be woken up by reading or writing any registers. There is no magnetometer measurement in the Standby mode. Internal clocking is also halted.

6.2.3 Self-Test Mode

To check the QMC6983 for proper operation, a self-test feature is incorporated in which the sensor is internally excited with a nominal magnetic field, This field is then measured and reported. This function is enabled by changing register (09H) to mode =10. Then the self-test data can be obtained in the data output registers. By using this built-in function, the manufacturer can quickly verify the sensor's full functionality after the assembly without additional test setup.

7 Application Examples

7.1 Continuous Mode Setup Example

♦ Write Register 0BH by 0xFF (Define Set/Reset period, not recommend to change)

 \diamond Write Register 09H by 0x3D (Define OSR = 512, Full Scale Range = 20 Gauss, ODR = 200Hz, set continuous measurement mode)

7.2 Measurement Example

- ♦ Check status register 06H[0] ,"1" means ready.
- \diamond Read data register 00H ~ 05H.

7.3 Self-test Example

- ♦ Write Register 09H by 0x32 (Full Scale Range = 20 Gauss, not recommend to change)
- ♦ Waiting 3 millisecond until measurement ends
- ♦ Read data Register 00H ~ 05H
- ♦ Check data if within specification

7.4 Standby Example

♦ Write Register 09H by 0x00

7.5 Soft Reset Example

♦ Write Register 0AH by 0x80

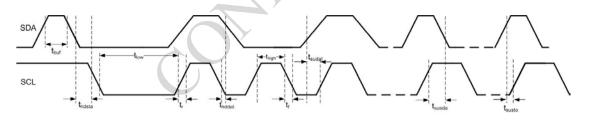
8 I²C COMMUNICATION PROTOCOL

8.1 I²C Timings

Below table and graph describe the I²C communication protocol times

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
SCL Clock	f_{scl}		0		400	kHz
SCL Low Period	tlow		1			μS
SCL High Period	t _{high}		1			μS
SDA Setup Time	t _{sudat}		0.1			μS
SDA Hold Time	t _{hddat}		0		0.9	μS
Start Hold Time	t _{hdsta}		0.6			μS
Start Setup Time	t _{susta}		0.6			μS
Stop Setup Time	t _{susto}	A	0.6			μS
New Transmission Time	t _{buf}		1.3			μS
Rise Time	t _r					μS
Fall Time	t _f	\mathbf{X}				μS

Table 9. I²C Timings



I²C Timing Diagram

Figure 14. I²C Timing Diagram

8.2 I²C R/W Operation

8.2.1 Abbreviation

Table 10. Abbreviation

SACK	Acknowledged by slave
MACK	Acknowledged by master
NACK	Not acknowledged by master
RW	Read/Write

8.2.2 Start/Stop/Ack

START: Data transmission begins with a high to transition on SDA while SCL is held high. Once I²C transmission starts, the bus is considered busy.

STOP: STOP condition is a low to high transition on SDA line while SCL is held high.

ACK: Each byte of data transferred must be acknowledged. The transmitter must release the SDA line during the acknowledge pulse while the receiver mush then pull the SDA line low so that it remains stable low during the high period of the acknowledge clock cycle.

NACK: If the receiver doesn't pull down the SDA line during the high period of the acknowledge clock cycle, it's recognized as NACK by the transmitter.

8.2.3 I^2 C Write

I²C write sequence begins with start condition generated by master followed by 7 bits slave address and a write bit (R/W=0). The slave sends an acknowledge bit (ACK=0) and releases the bus. The master sends the one byte register address. The slave again acknowledges the transmission and waits for 8 bits data which shall be written to the specified register address. After the slave acknowledges the data byte, the master generates a stop signal and terminates the writing protocol.

Table 11.	I ² C Write
-----------	------------------------

				-																								
		SI	ave	e Ao	ddre	ess		R			Re	egis	ster	Ad	dre	SS						Da	ata					
ST								W	SÞ				(0x	09)				Ş	(0x01)					ζ2	N			
AR	0	0	0	1	1	0	0	0	5	0	0	0	0	1	0	0	1	ç	0	0	0	0	0	0	0	1	Ś	-Ор
									\sim												1							Ŭ

8.2.4 I²C Read

 I^2C write sequence consists of a one-byte I^2C write phase followed by the I^2C read phase. A start condition must be generated between two phase. The I^2C write phase addresses the slave and sends the register address to be read. After slave acknowledges the transmission, the master generates again a start condition and sends the slave address together with a read bit (R/W=1). Then master releases the bus and waits for the data bytes to be read out from slave. After each data byte the master has to generate an acknowledge bit (ACK = 0) to enable further data transfer. A NACK from the master stops the data being transferred from the slave. The slave releases the bus so that the master can generate a STOP condition and terminate the transmission.

The register address is automatically incremented and more than one byte can be sequentially read out. Once a new data read transmission starts, the start address will be set to the register address specified in the current I²C write command.

Table 12. I²C Read

Tub						~																						
S		SI	ave	e Ao	ddre	ess		R W	S	Register Address (0x09)					S													
START	0	0	0	1	1	0	0	0	SACK	0	0	0	0	1	0	0	1	SACK										
ST		SI	ave	e Ac	ddre	ess		R W	łS		Re	egis		Ad 09)		SS		M,				Da (0x						
START	0	0	0	1	1	0	0	1	SACK	0	0	0	0	1	0	0	1	MACK	0	0	0	0	0	0	0	1		
M,)ata x02			1	M,									M,				Da (0x					NA	S
MACK	0	0	0	0	0	0	1	0	MACK	•••								MACK	0	0	0	0	0	1	1	1	ACK	STOP

8.2.5 I²C Pointer Roll-over

QMC6983 has an embedded I²C pointer roll-over function which can improve the data transmission efficiency. The I²C data pointer will automatically roll between 00H ~ 06H if I²C read begins at any position among 00H~06H. This function is enabled by set 0AH[6] = 01H.

9 **REGISTERS**

9.1 Register Map

The table below provides a list of the 8-bit registers embedded in the device and their respective function and addresses

Table 13. Register Map

Addr.	7	6	5	4	3	2	1	0	Access				
00H	Data Ou	tput X LSE	B Register	XOUT[7	:0]				Read only				
01H		Data Output X MSB Register XOUT[15:8]											
02H	Data Ou	tput Y LSE	3 Register	YOUT[7:0)]				Read only				
03H	Data Ou	tput Y MS	B Register	r YOUT[15	5:8]				Read only				
04H		Data Output Z LSB Register ZOUT[7:0]											
05H	Data Ou		Read only										
06H						DOR	OVL	DRD	Read only				
								Y					
07H	TOUT[7:	:0]							Read only				
08H	TOUT[1	5:8]							Read only				
09H	OSR[1:0]	RNG[1:0]	ODR[1:0	D]	MODE[1:0]	Read/Write				
0AH	SOFT_	ROL_P		LFSR_				INT_	R/W, Read				
	RST	NT		START				ENB	only on				
									blanks				
0BH	SET/RE	SET Perio	d FBR [7:0	D]			X		Read/Write				
0CH	Reserve		Read only										
0DH	Reserve		Read only										
0EH-	Encrypti		Read/Write										
11H						7							

9.2 Register Definition

9.2.1 Output Data Register

Registers $00H \sim 05H$ store the measurement data from each axis magnetic sensor in continuous-measurement or self-test modes. In the continuous measurement mode, the output data is refreshed periodically based on the data update rate ODR setup in control registers 1. The data stays the same, regardless of reading status through I^2C , until new data replaces them. Each axis has 16 bit data width in 2's complement, i.e., MSB of 01H/03H/05H indicates the sign of each axis. The output data of each channel saturates at -32768 and 32767.

Table 14.	Output	Data	Register
	Output	Dutu	regiotor

Addr.	7	6	5	4	3	2	1	0
00H	Data Ou	tput X LSE	3 Register	XOUT[7]	:0]			
01H	Data Ou	tput X MS	B Register	· XOUT[1	5:8]			
02H	Data Ou	tput Y LSE	3 Register	YOUT[7]	:0]			
03H	Data Ou	tput Y MS	B Register	· YOUT[1	5:8]			
04H	Data Ou	tput Z LSE	8 Register	ZOUT[7:	0]			
05H	Data Ou	tput Z MSI	B Register	ZOUT[15	5:8]			

9.2.2 Status Register

There are two status registers located in address 06H and 0CH.

Register 06H has three bits indicating for status flags, the rest are reserved for factory use. The status registers are read only bits.

Table 15. Status Register 1

Addr.	7	6	5	4	3	2	1	0
06H						DOR	OVL	DRDY

Data Ready Register (DRDY), it is set when all three axis data is ready, and loaded to the output data registers in the continuous measurement mode or in the self-test mode. It is reset to "0" by reading any data register (00H~05H) through I²C commends

DRDY: "0": no new data, "1": new data is ready

Overflow flag (OVL) is set to "1" if any data of three axis magnetic sensor channels is out of range. The output data of each axis saturates at -32768 and 32767, if any of the axis exceeds this range, OVL flag is set to "1". This flag is reset to "0" if next measurement goes back to the range of (-32768, 32767), otherwise, it keeps as "1".

OVL: "0": normal, "1": data overflow

Data Skip (DOR) bit is set to "1" if all the channels of output data registers are skipped in reading in the continuous-measurement mode. It is reset to "0" by reading any data register (00H~05H) through I²C

DOR: "0": normal, "1": data skipped for reading

9.2.3 Temperature Data Registers

Registers 07H-08H store temperature sensor output data. 16 bits temperature sensor output is in 2's complement. Temperature sensor gain is factory-calibrated, but Its offset has not been compensated, only relative temperature value is accurate. The temperature coefficient is about 100 LSB/°C

Table 17. Temperature Sensor Output

Addr.	7	6	5	4	3	2	1	0
07H	TOUT[7:		l l	\mathbf{V}				
08H	TOUT[15	5:8]						

9.2.4 Control Registers

Two 8-bits registers are used to control the device configurations.

Control register 1 is located in address 09H, it sets the operational modes (MODE). output data update rate (ODR), magnetic field measurement range or sensitivity of the sensors (RNG) and over sampling rate (OSR). Control register 2 is located in address 0AH. It controls Interrupt Pin enabling (INT_ENB), Point roll over function enabling(POL_PNT) and soft reset (SOFT_RST).

Two bits of MODE registers can transfer mode of operations in the device, the three modes are Standby, Continuous measurements and self-test. The default mode after Power-on-Reset (POR) is standby. There is no any restriction in the transferring among the three modes.

Output data rate is controlled by ODR registers. Four data update frequencies can be selected: 10Hz, 50Hz, 100Hz and 200Hz. For most of compassing applications, we recommend 10 Hz for low power consumption. For gaming, the high update rate such as 100Hz or 200Hz can be used.

Field ranges of the magnetic sensor can be selected through the register RNG. The full scale field range is determined by the application environments. For magnetic clear environment, low field range such as +/- 2gauss can be used. The field range goes hand in hand with the sensitivity of the magnetic sensor. The lowest field range has the highest sensitivity, therefore, higher resolution. Four magnetic field ranges can be selected, 2Gauss, 8 gauss, 12 gauss and 20 gauss.

Over sample Rate (OSR) registers are used to control bandwidth of an internal digital filter. Larger OSR value

leads to smaller filter bandwidth, less in-band noise and higher power consumption. It could be used to reach a good balance between noise and power. Four over sample ratio can be selected, 64, 128, 256 or 512.

Table 18. Control Register 1

Addr	7	6	5	4	3	2	1	0
09H	OSR[1:0]		RNG[1:0]		ODR[1:0]		MODE[1:0]	
Reg.	Definition		00		01		10	11
Mode	Mode Control		Standby		Continuous		Self-	Reserve
							Test	
ODR	Output Data Rate		10Hz		50Hz		100Hz	200Hz
RNG	Full Scale		2G		8G		12G	20G
OSR	Over	Sample	512		256		128	64
	Ratio							

Interrupt enabling is controlled by register INT_ENB in control register 2. Once the interrupt is enabled, it will flag when new data is in Data Output Registers.

INT_ENB: "0": enable interrupt PIN, "1": disable interrupt PIN

Pointer roll-over function is controlled by ROL_PNT register. When the point roll-over function is enabled, the I^2C data pointer automatically rolls between 00H ~ 06H, if I^2C read begins at any address among 00H~06H.

ROL_PNT: "0": Normal, "1": Enable pointer roll-over function

Soft Reset can be done by changing the register SOFT_RST to set. Soft reset can be invoked at any time of any mode. For example, if soft reset occurs at the middle of continuous mode reading, QMC6983 immediately switches to standby mode due to mode register is reset to "00" in default.

SOFT_RST: "0": Normal"1": Soft reset, restore default value of all registers.

Table 19. Control Register 2

Addr.	7	6	5	4	3	2	1	0
0AH	SOFT_R	ROL_PN						INT_ENB
	ST	Т						

9.2.5 SET/RESET Period Register

SET/RESET Period is controlled by FBR [7:0], it is recommended that the register 0BH is written by 0xFF, not change to any other value.

Table 20. SET/RESET Period Register

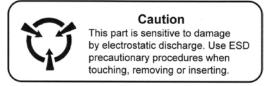
Addr.	7	6	5	4	3	2	1	0
0BH	SET/RESET Period FBR [7:0]							

9.2.6 Encryption Registers

0EH-11H is used for encryption code.

ORDERING INFORMATION

Ordering Number	Temperature Range	Package	Packaging
QMC6983-TR	-40℃~85℃	LGA-12	Tape and Reel: 5k pieces/reel



CAUTION: ESDS CAT. 1B

FIND OUT MORE

For more information on QST's Magnetic Sensors contact us at 86-21-50496156.

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U.S. Patents 4,441,072, 4,533,872, 4,569,742, 4,681,812, 4,847,584 and 6,529,114 apply to the technology described.



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